

32K x 9 Bit BurstRAM™

Synchronous Static RAM

With Burst Counter and Self-Timed Write

The MCM62940B is a 294,912 bit synchronous static random access memory designed to provide a burstable, high-performance, secondary cache for the MC68040 and PowerPC™ microprocessors. It is organized as 32,768 words of 9 bits, fabricated using Motorola's high-performance silicon-gate CMOS technology. The device integrates input registers, a 2-bit counter, high speed SRAM, and high drive capability outputs onto a single monolithic circuit for reduced parts count implementation of cache data RAM applications. Synchronous design allows precise cycle control with the use of an external clock (K). CMOS circuitry reduces the overall power consumption of the integrated functions for greater reliability.

Addresses (A0 – A14), data inputs (DQ0 – DQ8), and all control signals, except output enable (\overline{G}), are clock (K) controlled through positive-edge-triggered noninverting registers.

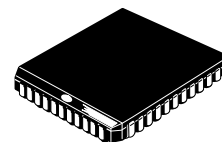
Bursts can be initiated with either transfer start processor (\overline{TSP}) or transfer start cache controller (\overline{TSC}) input pins. Subsequent burst addresses are generated internally by the MCM62940B (burst sequence imitates that of the MC68040 and PowerPC) and controlled by the burst address advance (\overline{BAA}) input pin. The following pages provide more detailed information on burst controls.

Write cycles are internally self-timed and are initiated by the rising edge of the clock (K) input. This feature eliminates complex off-chip write pulse generation and provides increased flexibility for incoming signals.

The MCM62940B is packaged in a 44-pin plastic-leaded chip carrier (PLCC). Multiple power and ground pins have been utilized to minimize effects induced by output noise. Separate power and ground pins have been employed for DQ0 – DQ8 to allow user-controlled output levels of 5 volts or 3.3 volts.

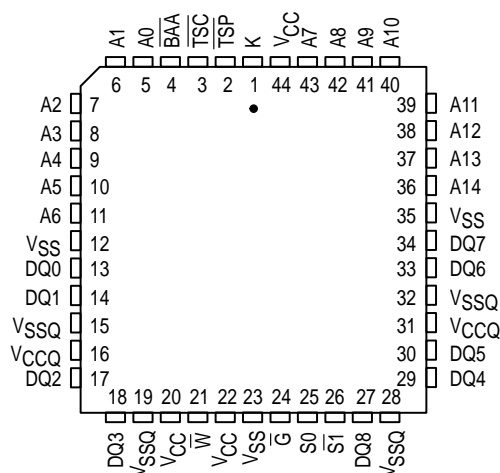
- Single 5 V \pm 10% Power Supply (\pm 5% for MCM62940BFN11)
- Choice of 5 V or 3.3 V \pm 10% Power Supplies for Output Level Compatibility
- Fast Access Times: 11/12/14/19 ns Max, Cycle Times: 15/20/20/25 ns Min
- Internal Input Registers (Address, Data, Control)
- Internally Self-Timed Write Cycle
- \overline{TSP} , \overline{TSC} , and \overline{BAA} Burst Control Pins
- Asynchronous Output Enable Controlled Three-State Outputs
- Common Data Inputs and Data Outputs
- High Output Drive Capability: 85 pF per I/O
- High Board Density PLCC Package
- Fully TTL-Compatible
- Active High and Low Chip Select Inputs for Easy Depth Expansion

MCM62940B



FN PACKAGE
44-LEAD PLCC
CASE 777-02

PIN ASSIGNMENT



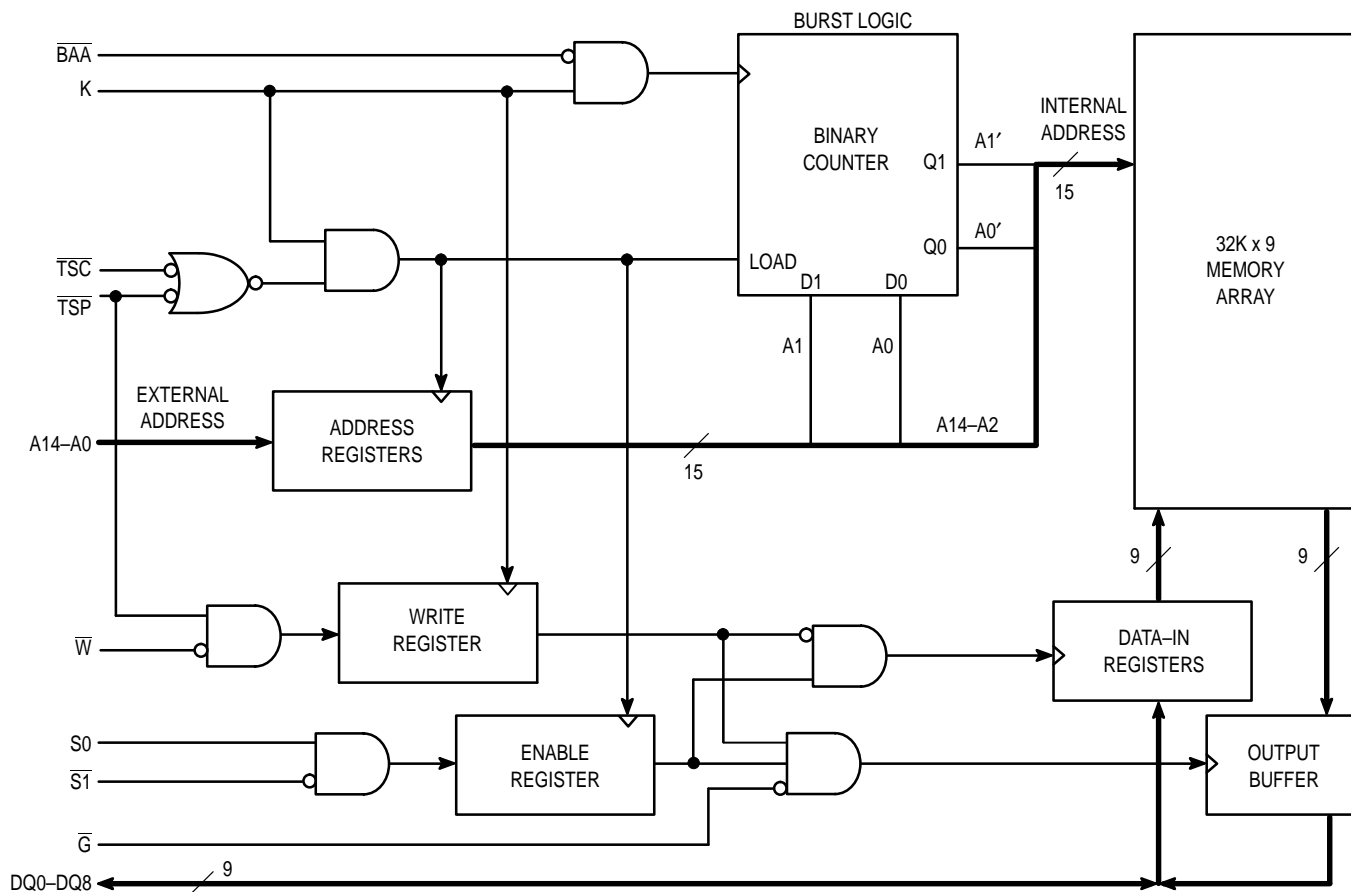
PIN NAMES

| | |
|-------------------------------------|----------------------------|
| A0 – A14 | Address Inputs |
| K | Clock |
| \overline{W} | Synchronous Write |
| \overline{G} | Output Enable |
| S0, $\overline{S1}$ | Chip Selects |
| \overline{BAA} | Burst Address Advance |
| \overline{TSP} , \overline{TSC} | Transfer Start |
| DQ0 – DQ8 | Data Input/Output |
| VCC | + 5 V Power Supply |
| VCCQ | Output Buffer Power Supply |
| VSS | Ground |
| VSSQ | Output Buffer Ground |

All power supply and ground pins must be connected for proper operation of the device.
 $V_{CC} \geq V_{CCQ}$ at all times including power up.

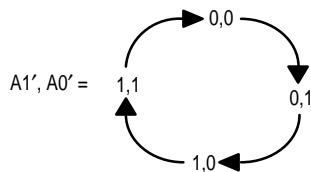
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PowerPC is a trademark of IBM Corp.

BLOCK DIAGRAM (See Note)



NOTE: All registers are positive-edge triggered. The \overline{TSC} or \overline{TSP} signals control the duration of the burst and the start of the next burst. When \overline{TSP} is sampled low, any ongoing burst is interrupted and a read (independent of \overline{W} and \overline{TSC}) is performed using the new external address. When \overline{TSC} is sampled low (and \overline{TSP} is sampled high), any ongoing burst is interrupted and a read or write (dependent on \overline{W}) is performed using the next external address. Chip selects ($S0$, $\overline{S1}$) are sampled only when a new base address is loaded. After the first cycle of the burst, \overline{BAA} controls subsequent burst cycles. When \overline{BAA} is sampled low, the internal address is advanced prior to the operation. When \overline{BAA} is sampled high, the internal address is not advanced, thus inserting a wait state into the burst sequence accesses. Upon completion of a burst, the address will wrap around to its initial state. See **BURST SEQUENCE GRAPH**.

BURST SEQUENCE GRAPH (See Note)



NOTE: The external two values for $A1$ and $A0$ provide the starting point for the burst sequence graph. The burst logic advances $A1$ and $A0$ as shown above.

SYNCHRONOUS TRUTH TABLE (See Notes 1, 2, 3, and 4)

| S | TSP | TSC | BAA | W | K | Address | Operation |
|---|-----|-----|-----|---|-----|------------------|-----------------------------|
| F | L | X | X | X | L–H | N/A | Deselected |
| F | X | L | X | X | L–H | N/A | Deselected |
| T | L | X | X | X | L–H | External Address | Read Cycle, Begin Burst |
| T | H | L | X | L | L–H | External Address | Write Cycle, Begin Burst |
| T | H | L | X | H | L–H | External Address | Read Cycle, Begin Burst |
| X | H | H | L | L | L–H | Next Address | Write Cycle, Continue Burst |
| X | H | H | L | H | L–H | Next Address | Read Cycle, Continue Burst |
| X | H | H | H | L | L–H | Current Address | Write Cycle, Suspend Burst |
| X | H | H | H | H | L–H | Current Address | Read Cycle, Suspend Burst |

NOTES:

1. X means Don't Care.
2. All inputs except \bar{G} must meet setup and hold times for the low-to-high transition of clock (K).
3. S represents S0 and $\bar{S}1$. T implies S0 = H and $\bar{S}1$ = L; F implies S0 = L or $\bar{S}1$ = H.
4. Wait states are inserted by suspending burst.

ASYNCHRONOUS TRUTH TABLE (See Notes 1 and 2)

| Operation | \bar{G} | I/O Status |
|------------|-----------|----------------------------|
| Read | L | Data Out (DQ0–DQ8) |
| Read | H | High–Z |
| Write | X | High–Z — Data In (DQ0–DQ8) |
| Deselected | X | High–Z |

NOTES:

1. X means Don't Care.
2. For a write operation following a read operation, \bar{G} must be high before the input data require setup time and held high throughout the input data hold time.

ABSOLUTE MAXIMUM RATINGS (Voltages referenced to $V_{SS} = 0$)

| Rating | Symbol | Value | Unit |
|------------------------------|-------------------|-------------------------|------|
| Power Supply Voltage | V_{CC} | – 0.5 to 7.0 | V |
| Output Power Supply Voltage | V_{CCQ} | – 0.5 to V_{CC} | V |
| Voltage Relative to V_{SS} | V_{in}, V_{out} | – 0.5 to $V_{CC} + 0.5$ | V |
| Output Current (per I/O) | I_{out} | ± 20 | mA |
| Power Dissipation | P_D | 1.0 | W |
| Temperature Under Bias | T_{bias} | – 10 to + 85 | °C |
| Operating Temperature | T_A | 0 to + 70 | °C |
| Storage Temperature | T_{stg} | – 55 to + 125 | °C |

NOTE: Permanent device damage may occur if ABSOLUTE MAXIMUM RATINGS are exceeded. Functional operation should be restricted to RECOMMENDED OPERATING CONDITIONS. Exposure to higher than recommended voltages for extended periods of time could affect device reliability.

This device contains circuitry to protect the inputs against damage due to high static voltages or electric fields; however, it is advised that normal precautions be taken to avoid application of any voltage higher than maximum rated voltages to this high-impedance circuit.

This CMOS memory circuit has been designed to meet the dc and ac specifications shown in the tables, after thermal equilibrium has been established.

DC OPERATING CONDITIONS AND CHARACTERISTICS

(V_{CC} , $V_{CCQ} = 5.0 \text{ V} \pm 5\%$, $T_A = 0$ to $+70^\circ\text{C}$, for device MCM62940B–11)
($V_{CC} = 5.0 \text{ V} \pm 10\%$, $V_{CCQ} = 5.0 \text{ V}$ or $3.3 \text{ V} \pm 10\%$, $T_A = 0$ to $+70^\circ\text{C}$, for all other devices)

RECOMMENDED OPERATING CONDITIONS (Voltages referenced to $V_{SS} = 0 \text{ V}$)

| Parameter | Symbol | Min | Typ | Max | Unit |
|--|-----------|------------|------------|----------------|------|
| Supply Voltage (Operating Voltage Range) | V_{CC} | 4.5 | 5.0 | 5.5 | V |
| Output Buffer Supply Voltage (5.0 V TTL Compatible) (3.3 V 50 Ω Compatible) | V_{CCQ} | 4.5 3.0 | 5.0 3.3 | 5.5 3.6 | V |
| Input High Voltage | V_{IH} | 2.2 | — | $V_{CC} + 0.3$ | V |
| Input Low Voltage | V_{IL} | -0.5^* | — | 0.8 | V |

* $V_{IL}(\text{min}) = -3.0 \text{ V}$ ac (pulse width $\leq 20 \text{ ns}$)

DC CHARACTERISTICS

| Parameter | Symbol | Min | Max | Unit |
|---|--------------|-----|-----------|---------------|
| Input Leakage Current (All Inputs, $V_{in} = 0$ to V_{CC}) | $I_{lkg(I)}$ | — | ± 1.0 | μA |
| Output Leakage Current (\overline{G} , $\overline{S1} = V_{IH}$, $S0 = V_{IL}$, $V_{out} = 0$ to V_{CCQ}) | $I_{lkg(O)}$ | — | ± 1.0 | μA |
| AC Supply Current (\overline{G} , $\overline{S1} = V_{IL}$, $S0 = V_{IH}$, All Inputs = $V_{IL} = 0 \text{ V}$ and $V_{IH} \geq 3.0 \text{ V}$, $I_{out} = 0 \text{ mA}$, Cycle Time $\geq t_{KHKH} \text{ min}$) | I_{CCA} | — | 160 | mA |
| Standby Current ($\overline{S1} = V_{IH}$, $S0 = V_{IL}$, All Inputs = V_{IL} and V_{IH} , Cycle Time $\geq t_{KHKH} \text{ min}$) | I_{SB1} | — | 50 | mA |
| Output Low Voltage ($I_{OL} = +8.0 \text{ mA}$) | V_{OL} | — | 0.4 | V |
| Output High Voltage ($I_{OH} = -4.0 \text{ mA}$) | V_{OH} | 2.4 | — | V |

NOTE: Good decoupling of the local power supply should always be used. DC characteristics are guaranteed for all possible MC68040 and PowerPC bus cycles.

CAPACITANCE ($f = 1.0 \text{ MHz}$, $dV = 3.0 \text{ V}$, $T_A = 25^\circ\text{C}$, Periodically Sampled Rather Than 100% Tested)

| Characteristic | Symbol | Typ | Max | Unit |
|---|-----------|-----|-----|------|
| Input Capacitance (All Pins Except DQ0 – DQ8) | C_{in} | 2 | 3 | pF |
| Input/Output Capacitance (DQ0 – DQ8) | $C_{I/O}$ | 7 | 8 | pF |

AC OPERATING CONDITIONS AND CHARACTERISTICS

(V_{CC} , $V_{CCQ} = 5.0 \text{ V} \pm 5\%$, $T_A = 0 \text{ to } +70^\circ\text{C}$, for device MCM62940B-11)
($V_{CC} = 5.0 \text{ V} \pm 10\%$, $V_{CCQ} = 5.0 \text{ V}$ or $3.3 \text{ V} \pm 10\%$, $T_A = 0 \text{ to } +70^\circ\text{C}$, for all other devices)

Input Timing Measurement Reference Level 1.5 V
Input Pulse Levels 0 to 3.0 V
Input Rise/Fall Time 3 ns

Output Timing Reference Level 1.5 V
Output Load See Figure 1A Unless Otherwise Noted

READ/WRITE CYCLE TIMING (See Notes 1, 2, and 3)

| Parameter | Symbol | 62940B-11 | | 62940B-12 | | 62940B-14 | | 62940B-19 | | Unit | Notes |
|--|--|-----------|-----|-----------|-----|-----------|-----|-----------|-----|------|-------|
| | | Min | Max | Min | Max | Min | Max | Min | Max | | |
| Cycle Time | t_{KHKH} | 15 | — | 20 | — | 20 | — | 25 | — | ns | |
| Clock Access Time | t_{KHQV} | — | 11 | — | 12 | — | 14 | — | 19 | ns | 4 |
| Output Enable to Output Valid | t_{GLQV} | — | 5 | — | 5 | — | 6 | — | 7 | ns | |
| Clock High to Output Active | t_{KHQX1} | 6 | — | 6 | — | 6 | — | 6 | — | ns | |
| Clock High to Output Change | t_{KHQX2} | 3 | — | 3 | — | 5 | — | 5 | — | ns | |
| Output Enable to Output Active | t_{GLQX} | 0 | — | 0 | — | 0 | — | 0 | — | ns | |
| Output Disable to Q High-Z | t_{GHQZ} | — | 6 | — | 6 | — | 6 | — | 7 | ns | 5 |
| Clock High to Q High-Z | t_{KHQZ} | — | 6 | — | 6 | — | 6 | — | 6 | ns | 5 |
| Clock High Pulse Width | t_{KHKL} | 5.5 | — | 7 | — | 8 | — | 9 | — | ns | |
| Clock Low Pulse Width | t_{KLKH} | 5.5 | — | 7 | — | 8 | — | 9 | — | ns | |
| Setup Times: Address Address Status Data In Write Address Advance Chip Select | t_{AVKH} t_{TSVKH} t_{DVKH} t_{WVKH} t_{BAVKH} t_{S0VKH} t_{S1VKH} | 2 | — | 2 | — | 3 | — | 3 | — | ns | 6 |
| Hold Symbol Times: Address Address Status Data In Write Address Advance Chip Select | t_{KHAX} t_{KHTSX} t_{KHDX} t_{KHVX} t_{KHBAX} t_{KHS0X} t_{KHS1X} | 2 | — | 2 | — | 2 | — | 2 | — | ns | 6 |

NOTES:

1. A read cycle is defined by \overline{W} high or \overline{TSP} low for the setup and hold times. A write cycle is defined by \overline{W} low and \overline{TSP} high for the setup and hold times.
2. All read and write cycle timings are referenced from K or \overline{G} .
3. \overline{G} is a don't care when \overline{W} is sampled low.
4. Maximum access times are guaranteed for all possible MC68040 and PowerPC external bus cycles.
5. Transition is measured $\pm 500 \text{ mV}$ from steady-state voltage with load of Figure 1B. This parameter is sampled and not 100% tested. At any given voltage and temperature, t_{KHQZ} max is less than t_{KHQX1} min for a given device and from device to device.
6. This is a synchronous device. All addresses must meet the specified setup and hold times for **ALL** rising edges of clock (K) whenever \overline{TSP} or \overline{TSC} are low and the chip is selected. All other synchronous inputs must meet the specified setup and hold times for **ALL** rising edges of K when the chip is selected. Chip select must be true ($\overline{S1}$ low and S0 high) at each rising edge of clock for the device (when \overline{TSP} or \overline{TSC} is low) to remain enabled. Timings for S1 and S0 are similar.

AC TEST LOADS

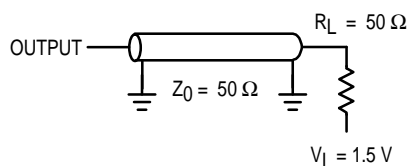


Figure 1A

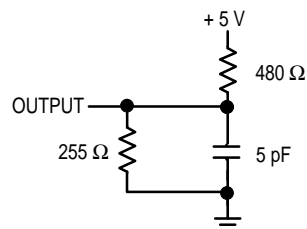
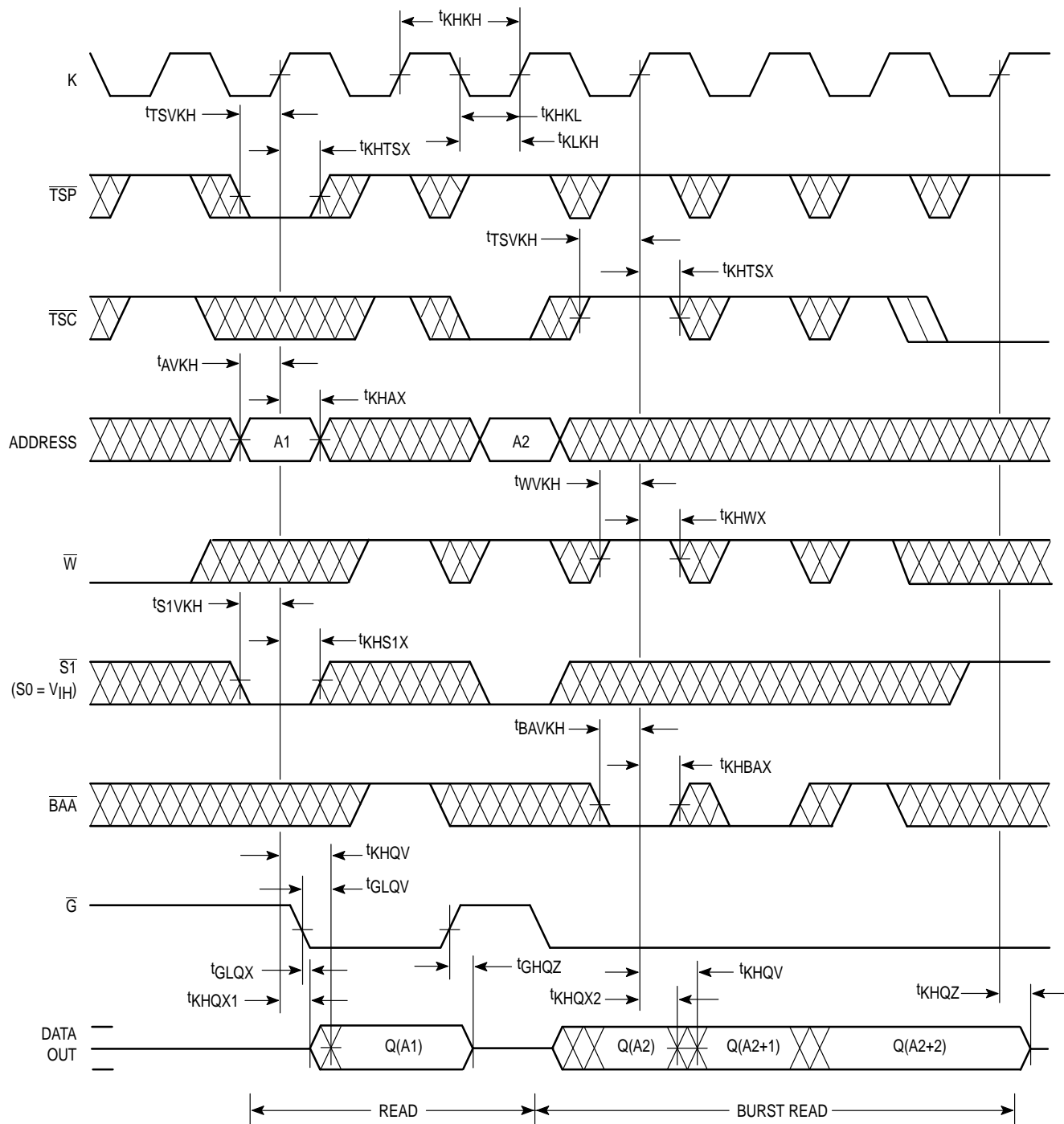


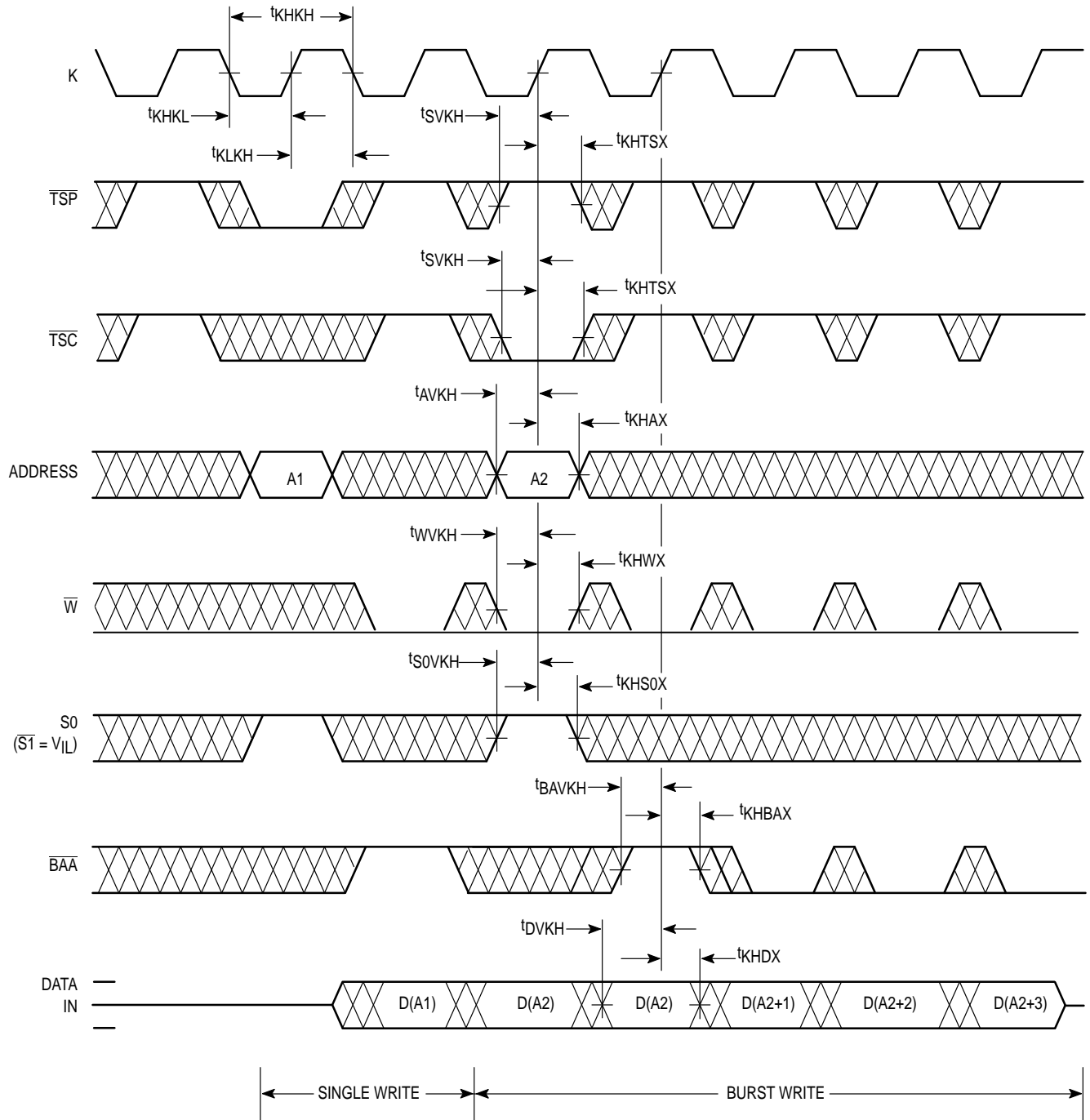
Figure 1B

READ CYCLES



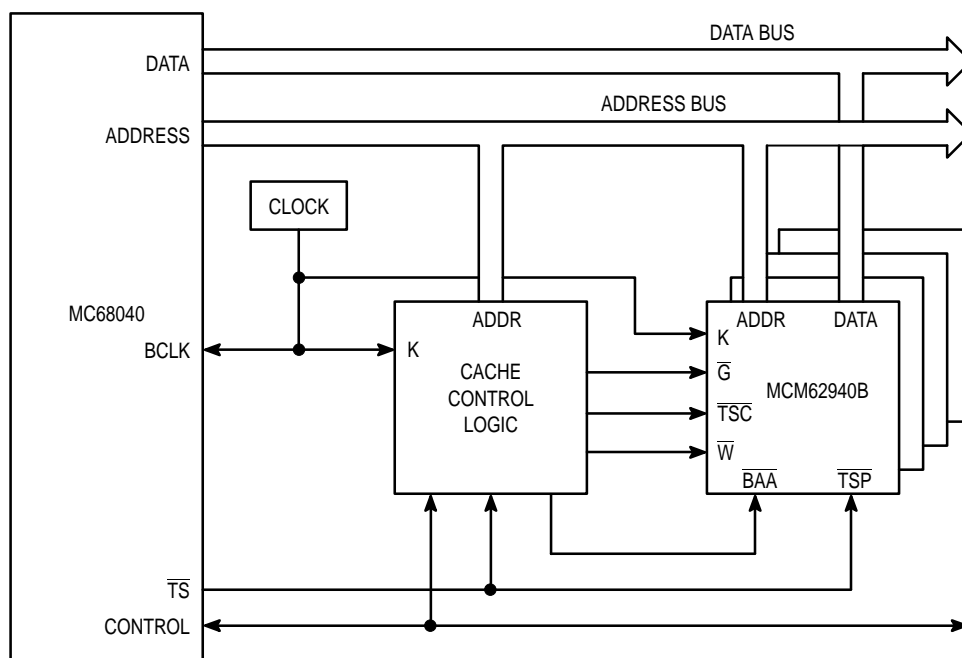
NOTE: Q(A2) represents the first output from the external address A2; Q(A2+1) represents the next output data in the burst sequence with A2 as the base address.

WRITE CYCLE



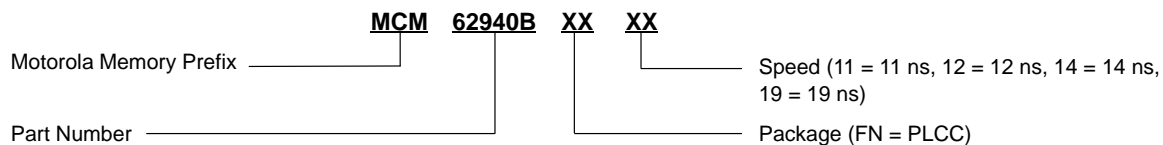
NOTE: $\overline{G} = V_{IH}$.

APPLICATION EXAMPLE



128K Byte Burstable, Secondary Cache
Using Four MCM62940BFN19s with a 33 MHz MC68040

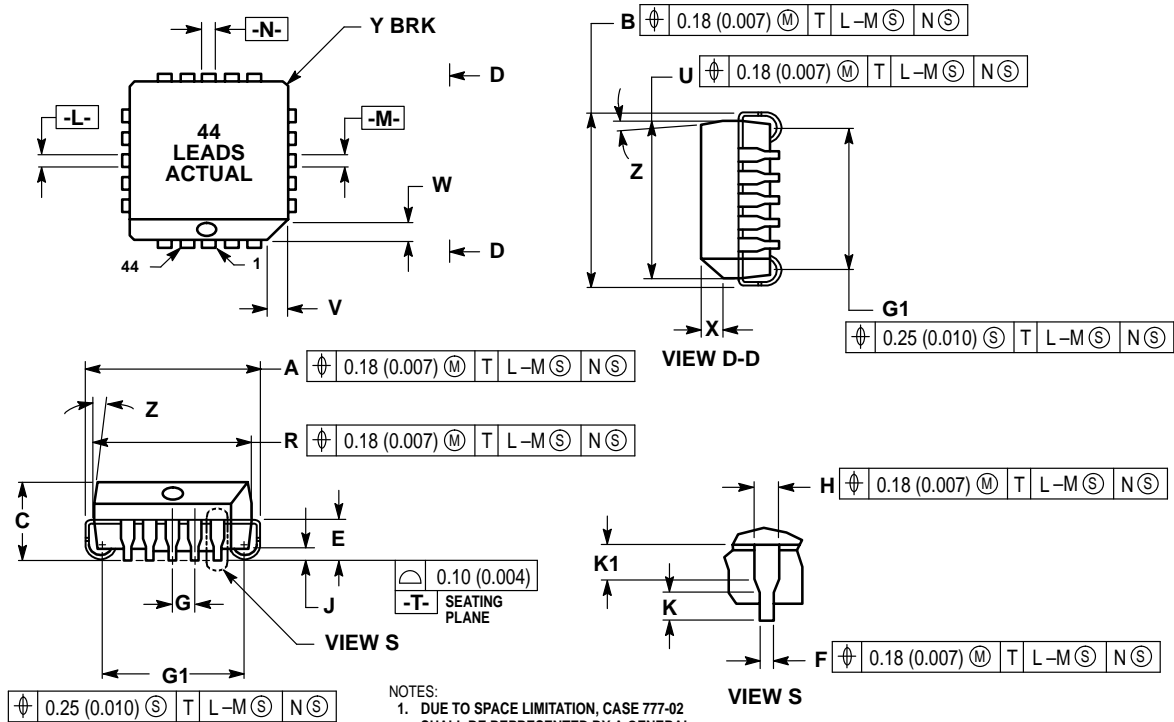
ORDERING INFORMATION (Order by Full Part Number)



Full Part Numbers — MCM62940BFN11 MCM62940BFN12 MCM62940BFN14 MCM62940BFN19


PACKAGE DIMENSIONS

FN PACKAGE 44-LEAD PLCC CASE 777-02



- NOTES:
1. DUE TO SPACE LIMITATION, CASE 777-02 SHALL BE REPRESENTED BY A GENERAL (SMALLER) CASE OUTLINE DRAWING RATHER THAN SHOWING ALL 44 LEADS.
 2. DATUMS -L-, -M-, AND -N- DETERMINED WHERE TOP OF LEAD SHOULDER EXITS PLASTIC BODY AT MOLD PARTING LINE.
 3. DIM G1, TRUE POSITION TO BE MEASURED AT DATUM -T-, SEATING PLANE.
 4. DIM R AND U DO NOT INCLUDE MOLD FLASH. ALLOWABLE MOLD FLASH IS 0.25 (0.010) PER SIDE.
 5. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 6. CONTROLLING DIMENSION: INCH.
 7. THE PACKAGE TOP MAY BE SMALLER THAN THE PACKAGE BOTTOM BY UP TO .012 (.300). DIMENSIONS R AND U ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY EXCLUSIVE OF MOLD FLASH, TIE BAR BURRS, GATE BURRS AND INTERLEAD FLASH, BUT INCLUDING ANY MISMATCH BETWEEN THE TOP AND BOTTOM OF THE PLASTIC BODY.
 8. DIMENSION H DOES NOT INCLUDE DAMBAR PROTRUSION OR INTRUSION. THE DAMBAR PROTRUSION(S) SHALL NOT CAUSE THE H DIMENSION TO BE GREATER THAN .037 (.940). THE DAMBAR INTRUSION(S) SHALL NOT CAUSE THE H DIMENSION TO BE SMALLER THAN .025 (.635).
 9. 777-01 IS OBSOLETE, NEW STANDARD 777-02.

| DIM | MILLIMETERS | | INCHES | |
|-----|-------------|-------|-----------|-------|
| | MIN | MAX | MIN | MAX |
| A | 17.40 | 17.65 | 0.685 | 0.695 |
| B | 17.40 | 17.65 | 0.685 | 0.695 |
| C | 4.20 | 4.57 | 0.165 | 0.180 |
| E | 2.29 | 2.79 | 0.090 | 0.110 |
| F | 0.33 | 0.48 | 0.013 | 0.019 |
| G | 1.27 BSC | | 0.050 BSC | |
| H | 0.66 | 0.81 | 0.026 | 0.032 |
| J | 0.51 | — | 0.020 | — |
| K | 0.64 | — | 0.025 | — |
| R | 16.51 | 16.66 | 0.650 | 0.656 |
| U | 16.51 | 16.66 | 0.650 | 0.656 |
| V | 1.07 | 1.21 | 0.042 | 0.048 |
| W | 1.07 | 1.21 | 0.042 | 0.048 |
| X | 1.07 | 1.42 | 0.042 | 0.056 |
| Y | — | 0.50 | — | 0.020 |
| Z | 2° | 10° | 2° | 10° |
| G1 | 15.50 | 16.00 | 0.610 | 0.630 |
| K1 | 1.02 | — | 0.040 | — |

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MCM62940B/D

